## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10586825	PARK ET AL.
Examiner	Art Unit
QUN SHEN	2617

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SEARCHED				
Class	Subclass	Date	Examiner	
370	315	2/2/2010	qs	
455	combined with text	2/2/2010	qs	
370	combined with text	2/2/2010	qs	

SEARCH NOTES		
Search Notes	Date	Examiner
Text search with EAST	2/2/2010	qs
international search report	2/2/2010	qs
inventor search	2/2/2010	qs

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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